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# Author index

Ager, F.J., S. Elmrabet, A. Paúl, Á. Cea-Naharro, M.D. Ynsa, M.A. Respaldiza and J.A. Odriozola, Determination of nitrogen in metallic phases using the $^{14}N(d, p\gamma)^{15}N$ nuclear reaction . . . 188 (2002) 96
Ahmed, S., R. Gwilliam and B.J. Sealy, Implant isolation in GaAs device technology: Effect of substrate temperature . . . 188 (2002) 196
Ahmed, S., see Too, P. . . . 188 (2002) 205
Alves, E., see Tavares, C.J. . . . 188 (2002) 90
Alves, E., N.P. Barradas, T. Monteiro, R. Correia and U. Kreissig, Ion beam studies of MBE grown GaN films on (111) silicon substrates . . . 188 (2002) 73
Alves, L.C., M.B.H. Breese, M.F. da Silva and J.C. Soares, A photomultiplier-based secondary electron imaging system for a nuclear microprobe . . . 188 (2002) 146
Amemiya, K., J. Ito, T. Ohno, T. Yasuda, T. Ohyanagi and A. Watanabe, Development of a continuously variable energy radio frequency quadrupole accelerator for SiC power semiconductor device fabrication . . . 188 (2002) 247
Andersson, G.G., see van IJzendoorn, L.J. . . . 188 (2002) 36
Aoki, M., see Hattori, T. . . . 188 (2002) 221

Barradas, N.P., see Alves, E. . . . 188 (2002) 73
Barradas, N.P., see Tavares, C.J. . . . 188 (2002) 90
Baving, P., see Vogel, T. . . . 188 (2002) 174
Becker, H.W., see Vogel, T. . . . 188 (2002) 174
Berger, A., see Ecker, K.H. . . . 188 (2002) 120
Bibic, N., see Milosavljevic, M. . . . 188 (2002) 166
Blamire, M., see Peng, N. . . . 188 (2002) 189
Blamire, M.G., see Kang, D.-J. . . . 188 (2002) 183
Bohne, W., S. Lindner and J. Röhrich, Study of In diffusion into ZnSe buffer-layer material of chalcopyrite solar cells with rough surfaces by means of ERDA measurements . . . 188 (2002) 55
Bošnjak, Ž., see Jakšić, M. . . . 188 (2002) 130
Bouquillon, A., J.-C. Dran, G. Lagarde, P. Martinetto, F. Mathis, B. Moignard, J. Salomon and Ph. Walter, In situ dynamic analysis of solids or aqueous solutions undergoing chemical reactions by RBS or PIXE with external beams . . . 188 (2002) 156
Breese, M.B.H., see Alves, L.C. . . . 188 (2002) 146
Breese, M.B.H., D.N. Jamieson and B.L. Doyle, The use of solenoid lenses in a two-stage nuclear microprobe probe-forming system . . . 188 (2002) 261
Burnell, G., see Kang, D.-J. . . . 188 (2002) 183
Burnet, N.G., see Kirkby, N.F. . . . 188 (2002) 210
Butz, T., see Reinert, T. . . . 188 (2002) 1

Calligaro, T., J.-C. Dran, B. Moignard, L. Pichon, J. Salomon and Ph. Walter, Ion beam analysis with external beams: Recent set-up improvements . . . 188 (2002) 135
Casini, G., see Taccetti, N. . . . 188 (2002) 255
Cea-Naharro, Á., see Ager, F.J. . . . 188 (2002) 96
Cerrina, C., A. Nejim, Y. Wang and P.L.F. Hemment, Carrier transport properties of ion beam synthesised $Si_{1-x}Ge_x$ alloy heavily doped with arsenic . . . 188 (2002) 170
Chakarov, I., see Peng, N. . . . 188 (2002) 189

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ELSEVIER

Nuclear Instruments and Methods in Physics Research B 188 (2002) 288–295

NIM B
Beam Interactions with Materials & Atoms

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# Author index

Ager, F.J., S. Elmrabet, A. Paúl, Á. Cea-Naharro, M.D. Ynsa, M.A. Respaldiza and J.A. Odriozola, Determination of nitrogen in metallic phases using the $^{14}N(d, p\gamma)^{15}N$ nuclear reaction . . . 188 (2002) 96
Ahmed, S., R. Gwilliam and B.J. Sealy, Implant isolation in GaAs device technology: Effect of substrate temperature . . . 188 (2002) 196
Ahmed, S., see Too, P. . . . 188 (2002) 205
Alves, E., see Tavares, C.J. . . . 188 (2002) 90
Alves, E., N.P. Barradas, T. Monteiro, R. Correia and U. Kreissig, Ion beam studies of MBE grown GaN films on (111) silicon substrates . . . 188 (2002) 73
Alves, L.C., M.B.H. Breese, M.F. da Silva and J.C. Soares, A photomultiplier-based secondary electron imaging system for a nuclear microprobe . . . 188 (2002) 146
Amemiya, K., J. Ito, T. Ohno, T. Yasuda, T. Ohyanagi and A. Watanabe, Development of a continuously variable energy radio frequency quadrupole accelerator for SiC power semiconductor device fabrication . . . 188 (2002) 247
Andersson, G.G., see van IJzendoorn, L.J. . . . 188 (2002) 36
Aoki, M., see Hattori, T. . . . 188 (2002) 221

Barradas, N.P., see Alves, E. . . . 188 (2002) 73
Barradas, N.P., see Tavares, C.J. . . . 188 (2002) 90
Baving, P., see Vogel, T. . . . 188 (2002) 174
Becker, H.W., see Vogel, T. . . . 188 (2002) 174
Berger, A., see Ecker, K.H. . . . 188 (2002) 120
Bibic, N., see Milosavljevic, M. . . . 188 (2002) 166
Blamire, M., see Peng, N. . . . 188 (2002) 189
Blamire, M.G., see Kang, D.-J. . . . 188 (2002) 183
Bohne, W., S. Lindner and J. Röhrich, Study of In diffusion into ZnSe buffer-layer material of chalcopyrite solar cells with rough surfaces by means of ERDA measurements . . . 188 (2002) 55
Bošnjak, Ž., see Jakšić, M. . . . 188 (2002) 130
Bouquillon, A., J.-C. Dran, G. Lagarde, P. Martinetto, F. Mathis, B. Moignard, J. Salomon and Ph. Walter, In situ dynamic analysis of solids or aqueous solutions undergoing chemical reactions by RBS or PIXE with external beams . . . 188 (2002) 156
Breese, M.B.H., see Alves, L.C. . . . 188 (2002) 146
Breese, M.B.H., D.N. Jamieson and B.L. Doyle, The use of solenoid lenses in a two-stage nuclear microprobe probe-forming system . . . 188 (2002) 261
Burnell, G., see Kang, D.-J. . . . 188 (2002) 183
Burnet, N.G., see Kirkby, N.F. . . . 188 (2002) 210
Butz, T., see Reinert, T. . . . 188 (2002) 1

Calligaro, T., J.-C. Dran, B. Moignard, L. Pichon, J. Salomon and Ph. Walter, Ion beam analysis with external beams: Recent set-up improvements . . . 188 (2002) 135
Casini, G., see Taccetti, N. . . . 188 (2002) 255
Cea-Naharro, Á., see Ager, F.J. . . . 188 (2002) 96
Cerrina, C., A. Nejim, Y. Wang and P.L.F. Hemment, Carrier transport properties of ion beam synthesised $Si_{1-x}Ge_x$ alloy heavily doped with arsenic . . . 188 (2002) 170
Chakarov, I., see Peng, N. . . . 188 (2002) 189

PII: S0168-583X(02)00838-8

Chiari, M., A. Migliori and P.A. Mandò, Investigation of beam-induced damage to ancient ceramics in external-PIXE measurements . . . 188 (2002) 151
Chiari, M., A. Migliori and P.A. Mandò, Measurement of low currents in an external beam set-up. . . . 188 (2002) 162
Chiari, M., see Taccetti, N. . . . 188 (2002) 255
Christou, C. and J. Gordon, Numerical study of the two-stage amplitude-controlled RF linear accelerator in the SWIFT ion implanter beamline . . . 188 (2002) 251
Clough, A.S., see Smith, R.W. . . . 188 (2002) 126
Colligon, J.S., see McKinty, C.N. . . . 188 (2002) 179
Correia, R., see Alves, E. . . . 188 (2002) 73
Cripps, G., see Ryan, C.G. . . . 188 (2002) 18

Dagkaldiran, Ü., see Vogel, T. . . . 188 (2002) 174
da Silva, M.F., see Alves, L.C. . . . 188 (2002) 146
de Jong, M.P., see van IJzendoorn, L.J. . . . 188 (2002) 36
de Voigt, M.J.A., see van IJzendoorn, L.J. . . . 188 (2002) 36
Ding, X.J., see Lin, W.L. . . . 188 (2002) 201
Ditrói, F., Determination of the charged particle beam energy/intensity uncertainties at multi-target irradiations 188 (2002) 115
Döbeli, M., see Kottler, C. . . . 188 (2002) 61
Doyle, B.L., see Breese, M.B.H. . . . 188 (2002) 261
Dran, J.-C., see Calligaro, T. . . . 188 (2002) 135
Dran, J.-C., see Bouquillon, A. . . . 188 (2002) 156
Drieberg, S.L., see Ryan, C.G. . . . 188 (2002) 18
Dudu, D., see Hattori, T. . . . 188 (2002) 221
Dudu, D., see Hata, T. . . . 188 (2002) 238

Ecker, K.H., U. Wätjen, A. Berger, L. Persson, W. Pritzkow, M. Radtke and H. Riesemeier, RBS, SY-XRF, INAA and ICP-IDMS of antimony implanted in silicon – A multi-method approach to characterize and certify a reference material . . . 188 (2002) 120
Edwards, S.P., see McKinty, C.N. . . . 188 (2002) 179
Elmrabet, S., see Ager, F.J. . . . 188 (2002) 96

Fanourakis, G., see Kokkoris, M. . . . 188 (2002) 78
Faraday, D.B.F., see Kirkby, N.F. . . . 188 (2002) 210
Fedi, M.E., see Taccetti, N. . . . 188 (2002) 255
Folkard, M., B. Vojnovic, K.M. Prise and B.D. Michael, The application of charged-particle microbeams in radiobiology. . . . 188 (2002) 49
Fröb, H., see Rebohle, L. . . . 188 (2002) 28
Fujisawa, T., see Hayashizaki, N. . . . 188 (2002) 243

Gebel, T., see Rebohle, L. . . . 188 (2002) 28
Giuntini, L., see Taccetti, N. . . . 188 (2002) 255
Golser, R., see Steier, P. . . . 188 (2002) 283
González-Labajo, J., see Martín, J.E. . . . 188 (2002) 102
Gordon, J., see Christou, C. . . . 188 (2002) 251
Gracin, D., see Jakšić, M. . . . 188 (2002) 130
Grötzschel, R., see Kokkoris, M. . . . 188 (2002) 67
Gwilliam, R., see Ahmed, S. . . . 188 (2002) 196
Gwilliam, R., see Too, P. . . . 188 (2002) 205

Hata, T., see Hattori, T. . . . 188 (2002) 221
Hata, T., see Kashiwagi, H. . . . 188 (2002) 225
Hata, T., see Yamamoto, K. . . . 188 (2002) 229
Hata, T., T. Hattori, H. Kashiwagi, Y. Takahashi, K. Yamamoto, S. Matsui, D. Dudu, E. Osvath, I. Vata and S. Yamada, Design of heavy-ion APF-IH type linac for atomic physics and medical use. . . . 188 (2002) 238

Hata, T., see Takahashi, Y. ... 188 (2002) 278
Hattori, T., see Hata, T. ... 188 (2002) 238
Hattori, T., see Hayashizaki, N. ... 188 (2002) 243
Hattori, T., see Kashiwagi, H. ... 188 (2002) 225
Hattori, T., see Okamura, M. ... 188 (2002) 216
Hattori, T., see Takahashi, Y. ... 188 (2002) 278
Hattori, T., see Takeuchi, T. ... 188 (2002) 233
Hattori, T., see Yamamoto, K. ... 188 (2002) 229
Hayashizaki, N., see Okamura, M. ... 188 (2002) 216
Hattori, T., K. Yamamoto, N. Hayashizaki, H. Kashiwagi, Y. Takahashi, T. Hata, S. Okada, T. Sugita, M. Aoki, M. Okamura, S. Yamada, E. Osvath, D. Dudu and I. Vata, A study of a test APF-IH type linac as an injector for cancer therapy ... 188 (2002) 221
Hayashizaki, N., see Hattori, T. ... 188 (2002) 221
Hayashizaki, N., see Kashiwagi, H. ... 188 (2002) 225
Hayashizaki, N., see Yamamoto, K. ... 188 (2002) 229
Hayashizaki, N., see Takeuchi, T. ... 188 (2002) 233
Hayashizaki, N., T. Hattori, M. Odera, K. Nakayama, K. Isokawa, K. Sato and T. Fujisawa, Beam acceleration test of the Ridgetron electron accelerator ... 188 (2002) 243
Hayashizaki, N., see Takahashi, Y. ... 188 (2002) 278
Helm, M., see Rebohle, L. ... 188 (2002) 28
Hemment, P.L.F., see Cerrina, C. ... 188 (2002) 170
Hermanne, A., see Takács, S. ... 188 (2002) 106
Hnatowicz, V., see Macková, A. ... 188 (2002) 112
Homewood, K.P., see Milosavljevic, M. ... 188 (2002) 166
Homewood, K.P., see McKinty, C.N. ... 188 (2002) 179
Hüttel, I., see Macková, A. ... 188 (2002) 112

Isokawa, K., see Hayashizaki, N. ... 188 (2002) 243
Ito, J., see Amemiya, K. ... 188 (2002) 247

Jakšić, M., Ž. Bošnjak, D. Gracin, Z. Medunić, Ž. Pastuović, E. Vittone and F. Nava, Characterisation of SiC by IBIC and other IBA techniques ... 188 (2002) 130
Jameson, R.A., see Okamura, M. ... 188 (2002) 216
Jameson, R.A., see Takeuchi, T. ... 188 (2002) 233
Jamieson, D.N., see Breese, M.B.H. ... 188 (2002) 261
Janssen, F.J.J., see van IJzendoorn, L.J. ... 188 (2002) 36
Jeynes, C., G.G. Rozenberg, S.P. Speakman and J.H.G. Steinke, A microbeam RBS analysis of low temperature direct-write inkjet deposited copper ... 188 (2002) 141
Jeynes, C., see Milosavljevic, M. ... 188 (2002) 166
Jeynes, C., see Kang, D.-J. ... 188 (2002) 183
Jeynes, C., see Peng, N. ... 188 (2002) 189

Kang, D.-J., N.H. Peng, R. Webb, C. Jeynes, G. Burnell, J.H. Yun, S.H. Moon, B. Oh, E.J. Tarte, D.F. Moore, M. Kelly and M.G. Blamire, Irradiation damage technology for manufacturable Josephson junctions ... 188 (2002) 183
Kang, D.J., see Peng, N. ... 188 (2002) 189
Kashiwagi, H., see Hattori, T. ... 188 (2002) 221
Kashiwagi, H., see Yamamoto, K. ... 188 (2002) 229
Kashiwagi, H., see Hata, T. ... 188 (2002) 238
Kashiwagi, H., see Takahashi, Y. ... 188 (2002) 278
Kashiwagi, H., T. Hattori, N. Hayashizaki, M. Okamura, Y. Takahashi, T. Hata, K. Ymamoto, S. Okada and T. Sugita, Study of a four hole ECR ion source for a HIF injector ... 188 (2002) 225
Katayama, T., see Takeuchi, T. ... 188 (2002) 233
Katayama, T., see Okamura, M. ... 188 (2002) 216
Kelly, M., see Kang, D.-J. ... 188 (2002) 183
Kirkby, K.J., see McKinty, C.N. ... 188 (2002) 179

Kirkby, N.F., N.G. Burnet and D.B.F. Faraday, Mathematical modelling of the response of tumour cells to radiotherapy ... 188 (2002) 210
Kokkoris, M., C.C. Trapalis, S. Kossionides, R. Vlastou, B. Nsouli, R. Grötzschel, S. Spartalis, G. Kordas and Th. Paradellis, RBS and HIRBS studies of nanostructured $AgSiO_2$ sol–gel thin coatings ... 188 (2002) 67
Kokkoris, M., S. Kossionides, A. Kyriakis, K. Zachariadou, G. Fanourakis, R. Vlastou and Th. Paradellis, Study of the irradiation damage in SiC by ion channeling ... 188 (2002) 78
Kordas, G., see Kokkoris, M. ... 188 (2002) 67
Kossionides, S., see Kokkoris, M. ... 188 (2002) 67
Kossionides, S., see Kokkoris, M. ... 188 (2002) 78
Kottler, C., M. Döbeli, U. Krähenbühl and M. Nussbaumer, Exposure age dating by fluorine diffusion ... 188 (2002) 61
Krähenbühl, U., see Kottler, C. ... 188 (2002) 61
Kreissig, U., see Alves, E. ... 188 (2002) 73
Kubsky, S., see Vogel, T. ... 188 (2002) 174
Kutschera, W., see Steier, P. ... 188 (2002) 283
Kyriakis, A., see Kokkoris, M. ... 188 (2002) 78

Lagarde, G., see Bouquillon, A. ... 188 (2002) 156
Li, H., see Sundaravel, B. ... 188 (2002) 84
Liechtenstein, V., see Steier, P. ... 188 (2002) 283
Lin, W.L., J.M. Sang, X.J. Ding, J. Xu and X.M. Yuan, Microchemical and microstructural changes of Co cemented WC induced by ion implantation ... 188 (2002) 201
Lindner, S., see Bohne, W. ... 188 (2002) 55
Luo, E.Z., see Sundaravel, B. ... 188 (2002) 84

Macková, A., V. Peřina, V. Hnatowicz, P. Nekvindová, V. Prajzler, I. Hüttel and J. Špirková, Characterisation of hydrogen and erbium in carbon layers fabricated by PACVD for optical applications ... 188 (2002) 112
Mandò, P.A., see Chiari, M. ... 188 (2002) 151
Mandò, P.A., see Chiari, M. ... 188 (2002) 162
Mandò, P.A., see Taccetti, N. ... 188 (2002) 255
Mark, G., see Ryan, C.G. ... 188 (2002) 18
Martín, J.E., M.Á. Respaldiza and J. González-Labajo, The state of the Guadiamar riverbed after the environmental disaster of 1998 analysed by TTPIXE ... 188 (2002) 102
Martina, L., V. Nassisi, G. Raganato and A. Pedone, Electron beam propagation in a space-charge regime ... 188 (2002) 272
Martinetto, P., see Bouquillon, A. ... 188 (2002) 156
Mathis, F., see Bouquillon, A. ... 188 (2002) 156
Matsui, S., see Yamamoto, K. ... 188 (2002) 229
Matsui, S., see Hata, T. ... 188 (2002) 238
McInnes, B.M., see Ryan, C.G. ... 188 (2002) 18
McKinty, C.N., see Milosavljevic, M. ... 188 (2002) 166
McKinty, C.N., K.J. Kirkby, K.P. Homewood, S.P. Edwards, G. Shao, R. Valizadeh and J.S. Colligon, The properties of β-$FeSi_2$ fabricated by ion beam assisted deposition as a function of annealing conditions for use in solar cell applications ... 188 (2002) 179
Medunić, Z., see Jakšić, M. ... 188 (2002) 130
Meijer, J. and A. Stephan, Prospects of ion projection techniques for maskless implantation at high ion energies ... 188 (2002) 9
Meijer, J., see Vogel, T. ... 188 (2002) 174
Michael, B.D., see Folkard, M. ... 188 (2002) 49
Migliori, A., see Chiari, M. ... 188 (2002) 151
Migliori, A., see Chiari, M. ... 188 (2002) 162
Milosavljevic, M., G. Shao, N. Bibic, C.N. McKinty, C. Jeynes and K.P. Homewood, Synthesis of amorphous $FeSi_2$ by ion beam mixing ... 188 (2002) 166
Moignard, B., see Calligaro, T. ... 188 (2002) 135
Moignard, B., see Bouquillon, A. ... 188 (2002) 156
Monteiro, T., see Alves, E. ... 188 (2002) 73
Moon, S.H., see Kang, D.-J. ... 188 (2002) 183
Moore, D., see Peng, N. ... 188 (2002) 189
Moore, D.F., see Kang, D.-J. ... 188 (2002) 183

Nakayama, K., see Hayashizaki, N. ... 188 (2002) 243
Nassisi, V., A. Pedone and A. Rainò, Preliminary experimental results on an excimer laser ion source ... 188 (2002) 267
Nassisi, V., see Martina, L. ... 188 (2002) 272
Nava, F., see Jakšić, M. ... 188 (2002) 130
Nejim, A., see Cerrina, C. ... 188 (2002) 170
Nekvindová, P., see Macková, A. ... 188 (2002) 112
Noda, K., see Takahashi, Y. ... 188 (2002) 278
Nordlund, K., Computational materials science of ion irradiation ... 188 (2002) 41
Nsouli, B., see Kokkoris, M. ... 188 (2002) 67
Nussbaumer, M., see Kottler, C. ... 188 (2002) 61

Odera, M., see Hayashizaki, N. ... 188 (2002) 243
Odriozola, J.A., see Ager, F.J. ... 188 (2002) 96
Oh, B., see Kang, D.-J. ... 188 (2002) 183
Ohno, T., see Amemiya, K. ... 188 (2002) 247
Ohyanagi, T., see Amemiya, K. ... 188 (2002) 247
Okada, S., see Hattori, T. ... 188 (2002) 221
Okada, S., see Kashiwagi, H. ... 188 (2002) 225
Okamura, M., see Takeuchi, T. ... 188 (2002) 233
Okamura, M., T. Katayama, R.A. Jameson, T. Takeuchi, T. Hattori and N. Hayashizaki, Carbon beam acceleration using a simple injection method into an RFQ ... 188 (2002) 216
Okamura, M., see Hattori, T. ... 188 (2002) 221
Okamura, M., see Kashiwagi, H. ... 188 (2002) 225
Osvath, E., see Hattori, T. ... 188 (2002) 221
Osvath, E., see Hata, T. ... 188 (2002) 238

Pacaud, J., see Tavares, C.J. ... 188 (2002) 90
Paradellis, Th., see Kokkoris, M. ... 188 (2002) 67
Paradellis, Th., see Kokkoris, M. ... 188 (2002) 78
Pastuović, Ž., see Jakšić, M. ... 188 (2002) 130
Paúl, A., see Ager, F.J. ... 188 (2002) 96
Pedone, A., see Nassisi, V. ... 188 (2002) 267
Pedone, A., see Martina, L. ... 188 (2002) 272
Peng, N., C. Jeynes, R. Webb, I. Chakarov, D.J. Kang, D. Moore and M. Blamire, Monte Carlo simulations of energetic proton beam irradiation damage defect productions in YBCO thin films with Au masks ... 188 (2002) 189
Peng, N.H., see Kang, D.-J. ... 188 (2002) 183
Peřina, V., see Macková, A. ... 188 (2002) 112
Persson, L., see Ecker, K.H. ... 188 (2002) 120
Pichon, L., see Calligaro, T. ... 188 (2002) 135
Prajzler, V., see Macková, A. ... 188 (2002) 112
Priller, A., see Steier, P. ... 188 (2002) 283
Prise, K.M., see Folkard, M. ... 188 (2002) 49
Pritzkow, W., see Ecker, K.H. ... 188 (2002) 120

Radtke, M., see Ecker, K.H. ... 188 (2002) 120
Raganato, G., see Martina, L. ... 188 (2002) 272
Rainò, A., see Nassisi, V. ... 188 (2002) 267
Rebohle, L., J. von Borany, H. Fröb, T. Gebel, M. Helm and W. Skorupa, Ion beam synthesized nanoclusters for silicon-based light emission ... 188 (2002) 28
Rebouta, L., see Tavares, C.J. ... 188 (2002) 90
Reibetanz, U., see Reinert, T. ... 188 (2002) 1
Reinert, T., U. Reibetanz, M. Schwertner, J. Vogt, T. Butz and A. Sakellariou, The architecture of cartilage: Elemental maps and scanning transmission ion microscopy/tomography ... 188 (2002) 1
Respaldiza, M.A., see Ager, F.J. ... 188 (2002) 96
Respaldiza, M.Á., see Martín, J.E. ... 188 (2002) 102

Riesemeier, H., see Ecker, K.H. ... 188 (2002) 120
Rivière, J.P., see Tavares, C.J. ... 188 (2002) 90
Röcken, H., see Vogel, T. ... 188 (2002) 174
Röhrich, J., see Bohne, W. ... 188 (2002) 55
Rozenberg, G.G., see Jeynes, C. ... 188 (2002) 141
Ryan, C.G., E. van Achterbergh, C.J. Yeats, S.L. Drieberg, G. Mark, B.M. McInnes, T.T. Win, G. Cripps and G.F. Suter, Quantitative, high sensitivity, high resolution, nuclear microprobe imaging of fluids, melts and minerals ... 188 (2002) 18

Sakellariou, A., see Reinert, T. ... 188 (2002) 1
Sakumi, A., see Takeuchi, T. ... 188 (2002) 233
Salomon, J., see Calligaro, T. ... 188 (2002) 135
Salomon, J., see Bouquillon, A. ... 188 (2002) 156
Sang, J.M., see Lin, W.L. ... 188 (2002) 201
Sato, K., see Hayashizaki, N. ... 188 (2002) 243
Schwertner, M., see Reinert, T. ... 188 (2002) 1
Sealy, B.J., see Ahmed, S. ... 188 (2002) 196
Sealy, B.J., see Too, P. ... 188 (2002) 205
Shao, G., see Milosavljevic, M. ... 188 (2002) 166
Shao, G., see McKinty, C.N. ... 188 (2002) 179
Skorupa, W., see Rebohle, L. ... 188 (2002) 28
Smith, R.W. and A.S. Clough, Depth profiling of diffusion into cylindrical matrices using a scanning microbeam ... 188 (2002) 126
Soares, J.C., see Alves, L.C. ... 188 (2002) 146
Sonck, M., see Takács, S. ... 188 (2002) 106
Spartalis, S., see Kokkoris, M. ... 188 (2002) 67
Speakman, S.P., see Jeynes, C. ... 188 (2002) 141
Špirková, J., see Macková, A. ... 188 (2002) 112
Stefanini, A.A., see Taccetti, N. ... 188 (2002) 255
Steier, P., R. Golser, W. Kutschera, V. Liechtenstein, A. Priller, A. Valenta and C. Vockenhuber, Heavy ion AMS with a "small" accelerator ... 188 (2002) 283
Steinke, J.H.G., see Jeynes, C. ... 188 (2002) 141
Stephan, A., see Meijer, J. ... 188 (2002) 9
Stephan, A., see Vogel, T. ... 188 (2002) 174
Sturm, J.M., see van IJzendoorn, L.J. ... 188 (2002) 36
Sugai, I., see Takahashi, Y. ... 188 (2002) 278
Sugita, T., see Hattori, T. ... 188 (2002) 221
Sugita, T., see Kashiwagi, H. ... 188 (2002) 225
Sun, J.R., see Sundaravel, B. ... 188 (2002) 84
Sundaravel, B., I.H. Wilson, E.Z. Luo, J.B. Xu, H.W. Yeung, H. Li, C.F. Yeung, J.R. Sun and H.K. Wong, Resonant Rutherford backscattering spectrometry and channeling studies on the effect of annealing of $La_{0.67}Ca_{0.33}MnO_3$ epilayers grown on $SrTiO_3(001)$ substrates using a facing-target sputtering technique ... 188 (2002) 84
Suter, G.F., see Ryan, C.G. ... 188 (2002) 18

Taccetti, N., L. Giuntini, G. Casini, A.A. Stefanini, M. Chiari, M.E. Fedi and P.A. Mandò, The pulsed beam facility at the 3 MV Van de Graaff accelerator in Florence: Overview and examples of applications ... 188 (2002) 255
Takács, S., F. Tárkányi, M. Sonck and A. Hermanne, New cross-sections and intercomparison of proton monitor reactions on Ti, Ni and Cu ... 188 (2002) 106
Takahashi, Y., see Hattori, T. ... 188 (2002) 221
Takahashi, Y., see Kashiwagi, H. ... 188 (2002) 225
Takahashi, Y., see Yamamoto, K. ... 188 (2002) 229
Takahashi, Y., see Hata, T. ... 188 (2002) 238
Takahashi, Y., T. Hattori, H. Kashiwagi, T. Hata, N. Hayashizaki, I. Sugai and K. Noda, Pulsing system of $C_{60}$ beam for the TOF method ... 188 (2002) 278

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Takeuchi, T., see Okamura, M. . . . 188 (2002) 216
Tárkányi, F., see Takács, S. . . . 188 (2002) 106
Tarte, E.J., see Kang, D.-J. . . . 188 (2002) 183
Tavares, C.J., L. Rebouta, E. Alves, N.P. Barradas, J. Pacaud and J.P. Rivière, Study of roughness in $Ti_{0.4}Al_{0.6}N$/Mo multilayer structures . . . 188 (2002) 90
Too, P., S. Ahmed, R. Gwilliam and B.J. Sealy, Electrical isolation of n-type InP layers by helium implantation at variable substrate temperatures . . . 188 (2002) 205
Trapalis, C.C., see Kokkoris, M. . . . 188 (2002) 67

Valenta, A., see Steier, P. . . . 188 (2002) 283
Valizadeh, R., see McKinty, C.N. . . . 188 (2002) 179
van Achterbergh, E., see Ryan, C.G. . . . 188 (2002) 18
van IJzendoorn, L.J., M.P. de Jong, F.J.J. Janssen, G.G. Andersson, J.M. Sturm and M.J.A. de Voigt, Ion beam analysis at cryogenic temperatures for polymer light emitting diodes . . . 188 (2002) 36
Vata, I., see Hattori, T. . . . 188 (2002) 221
Vata, I., see Hata, T. . . . 188 (2002) 238
Vittone, E., see Jakšić, M. . . . 188 (2002) 130
Vlastou, R., see Kokkoris, M. . . . 188 (2002) 67
Vlastou, R., see Kokkoris, M. . . . 188 (2002) 78
Vockenhuber, C., see Steier, P. . . . 188 (2002) 283
Vogel, T., J. Meijer, A. Stephan, U. Weidenmüller, Ü. Dagkaldiran, S. Kubsky, P. Baving, H.W. Becker and H. Röcken, Ion beam synthesis of buried $CoSi_2$-structures . . . 188 (2002) 174
Vogt, J., see Reinert, T. . . . 188 (2002) 1
Vojnovic, B., see Folkard, M. . . . 188 (2002) 49
von Borany, J., see Rebohle, L. . . . 188 (2002) 28

Walter, Ph., see Calligaro, T. . . . 188 (2002) 135
Walter, Ph., see Bouquillon, A. . . . 188 (2002) 156
Wang, Y., see Cerrina, C. . . . 188 (2002) 170
Watanabe, A., see Amemiya, K. . . . 188 (2002) 247
Wätjen, U., see Ecker, K.H. . . . 188 (2002) 120
Webb, R., see Kang, D.-J. . . . 188 (2002) 183
Webb, R., see Peng, N. . . . 188 (2002) 189
Weidenmüller, U., see Vogel, T. . . . 188 (2002) 174
Wilson, I.H., see Sundaravel, B. . . . 188 (2002) 84
Win, T.T., see Ryan, C.G. . . . 188 (2002) 18
Wong, H.K., see Sundaravel, B. . . . 188 (2002) 84

Xu, J., see Lin, W.L. . . . 188 (2002) 201
Xu, J.B., see Sundaravel, B. . . . 188 (2002) 84

Yamada, S., see Hattori, T. . . . 188 (2002) 221
Yamada, S., see Hata, T. . . . 188 (2002) 238
Yamamoto, K., see Hattori, T. . . . 188 (2002) 221
Yamamoto, K., see Kashiwagi, H. . . . 188 (2002) 225
Yamamoto, K., T. Hattori, S. Matsui, T. Hata, N. Hayashizaki, H. Kashiwagi and Y. Takahashi, Acceleration test of APF-IH type implanter . . . 188 (2002) 229
Yamamoto, K., see Hata, T. . . . 188 (2002) 238
Yamamoto, K., S. Matsui, D. Dudu, E. Osvath, I. Vata and S. Yamada, T. Hata, T. Hattori, H. Kashiwagi, Y. Takahashi, Design of heavy-ion APF-IH type linac for atomic physics and medical use . . . 188 (2002) 238
Yano, K., see Takeuchi, T. . . . 188 (2002) 233

Yasuda, T., see Amemiya, K. ..... 188 (2002) 247
Yeats, C.J., see Ryan, C.G. ..... 188 (2002) 18
Yeung, C.F., see Sundaravel, B. ..... 188 (2002) 84
Yeung, H.W., see Sundaravel, B. ..... 188 (2002) 84
Ynsa, M.D., see Ager, F.J. ..... 188 (2002) 96
Yuan, X.M., see Lin, W.L. ..... 188 (2002) 201
Yun, J.H., see Kang, D.-J. ..... 188 (2002) 183

Zachariadou, K., see Kokkoris, M. ..... 188 (2002) 78